

U.S. Department of Commerce, Patent and Trademark Office					Atty Docket No.		Serial No.	
					2001-0008-1		09/854,097	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT					Applicant(s)			
(Use several sheets if necessary)					Peter C. Newman et al.			
					Filing Date		Group	
					May 11, 2001		2881	

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 JAN 08 2002
 PATENT & TRADEMARK OFFICE

U.S. Patent Documents							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
DM	AA	3,593,189	07/13/71	Buhrer	331	94.5	
	AB	4,697,270	09/29/87	Galkowski	372	34	
	AC	4,798,467	01/17/89	Wyeth et al.	356	349	
	AD	4,817,101	03/28/89	Wyeth et al.	372	32	
	AE	4,940,331	07/10/90	Wyeth et al.	356	349	
	AF	5,025,445	06/18/91	Anderson et al.	372	20	
	AG	5,095,492	03/10/92	Sandstrom	372	102	
	AH	5,128,601	07/07/92	Orbach et al.	372	30	
	AI	5,371,587	12/06/94	de Groot et al.	356	349	
	AJ	5,420,877	05/30/95	Sandstrom	372	34	
	AK	5,450,207	09/12/95	Fomenkov	356	416	
	AL	5,524,144	06/04/96	Suzuki	359	176	
	AM	5,656,882	08/12/97	Lazarus et al.	310	328	

Foreign Patent Documents							Translation	
	Document	Date	Country	Class	Subclass	Yes	No	
	AN							
	AO							
	AP							
	AQ							

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)		
DM	AR	Ishihara, T., et al., "Advanced Krypton Fluoride Excimer Laser for Microlithography," SPIE Vol. 1674, Optical/Laser Microlithography V (1992), pp. 473-485
DM	AS	"Introduction to Signal Condition for ICP® & Charge Piezoelectric Sensors", from website: www.pcb.com/tech_signal.html , ©copyright PCB Piezotronics 1999.
	AT	

Examiner Danielle Monblanc Date Considered 4-6-03

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.

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U.S. Patent Documents							
			Date	Name	Class	Subclass	Filing Date If Appropriate
DM	AU	5,691,989	11/25/97	Rakuljic	372	20	
	AV	5,706,301	01/06/98	Lagerström	372	32	
	AW	5,754,571	05/19/98	Endoh et al.	372	20	
	AX	5,852,621	12/22/98	Sandstrom	372	25	
	AY	5,870,420	02/09/99	Webb	372	58	
	AZ	5,978,405	11/02/99	Juhasz et al.	372	57	
	BA	5,991,324	11/23/99	Knowles et al.	372	57	
	BB	6,005,879	12/21/99	Sandstrom et al.	372	25	
	BC	6,038,055	03/14/00	Hänsch et al.	359	279	
	BD	6,078,599	06/20/00	Everage et al.	372	20	
	BE	6,109,574	08/29/00	Pan et al	248	176.1	
	BF	6,128,323	10/03/00	Myers et al	372	38	

Foreign Patent Documents							Translation	
			Date	Country	Class	Subclass	Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)		

Examiner <u>Darlene Moulleau</u>	Date Considered <u>4-6-03</u>
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